

Notice of References Cited	Application/Control No. 10/731,761	Applicant(s)/Patent Under Reexamination JUN ET AL.	
	Examiner Walter L. Lindsay, Jr.	Art Unit 2812	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,376,320	04-2002	Yu, Bin	438/303
	B	US-5,953,612	09-1999	Lin et al.	438/299
	C	US-4,877,755	10-1989	Rodder, Mark S.	438/586
	D	US-5,731,239	03-1998	Wong et al.	438/296
	E	US-5,766,997	06-1998	Takeuchi, Nobuyoshi	438/257
	F	US-5,766,990	06-1998	El-Diwany, Monir	438/202
	G	US-6,015,740	01-2000	Milic-Strkalj, Ognjen	438/300
	H	US-6,066,532	05-2000	Chen et al.	438/259
	I	US-6,162,691	12-2000	Huang, Kuei-Wu	438/300
	J	US-6,271,133	08-2001	Lim et al.	438/683
	K	US-6,376,320	04-2002	Yu, Bin	438/303
	L	US-6,413,807	07-2002	Mikagi, Kaoru	438/198
	M	US-6,423,634	07-2002	Wieczorek et al.	438/655

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.